

ASSP

Dual Serial Input PLL Frequency Synthesizer

MB15F78UL

■ DESCRIPTION

The Fujitsu Semiconductor MB15F78UL is a serial input Phase Locked Loop (PLL) frequency synthesizer with a 2600 MHz and a 1200 MHz prescalers. A 32/33 or a 64/65 for the 2600 MHz prescaler, and a 16/17 or a 32/33 for the 1200 MHz prescaler can be selected for the prescaler that enables pulse swallow operation.

The BiCMOS process is used, as a result a supply current is typically 4.5 mA at 2.7 V. The supply voltage range is from 2.4 V to 3.6 V. A refined charge pump supplies well-balanced output current with 1.5 mA and 6 mA selectable by serial date. The data format is the same as the previous one MB15F08SL, MB15F78SP. Fast locking is achieved for adopting the new circuit.

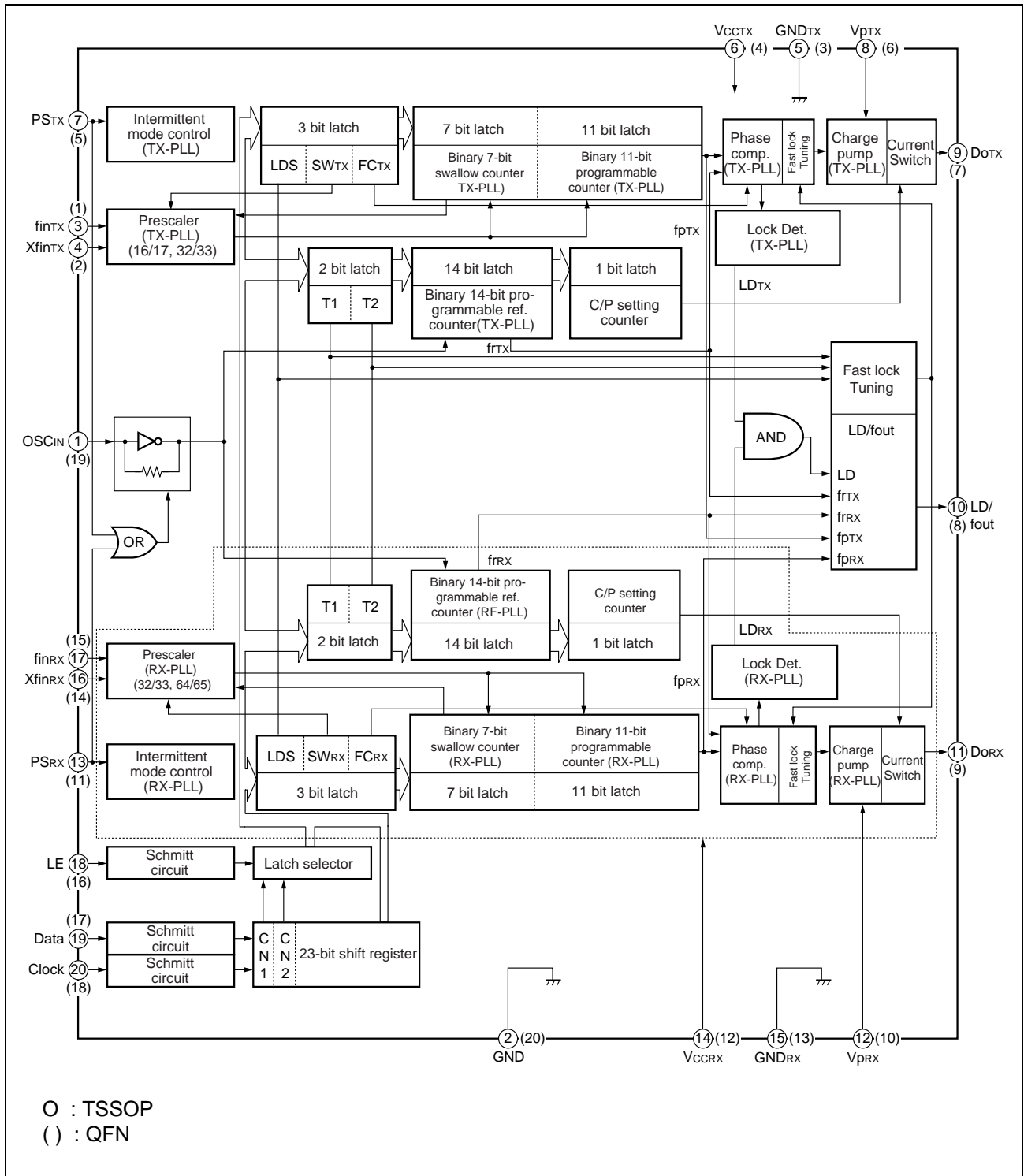
■ FEATURES

- High frequency operation : RX synthesizer : 2600 MHz Max
: TX synthesizer : 1200 MHz Max
- Low power supply voltage : $V_{CC} = 2.4$ to 3.6 V
- Ultra low power supply current : $I_{CC} = 4.5$ mA Typ
($V_{CC} = V_p = 2.7$ V, $T_a = +25$ °C, $SW_{TX} = SW_{RX} = 0$, in TX/RX locking state)
- Direct power saving function : Power supply current in power saving mode
Typ 0.1 μ A ($V_{CC} = V_p = 2.7$ V, $T_a = +25$ °C)
Max 10 μ A ($V_{CC} = V_p = 2.7$ V)
- Software selectable charge pump current : 1.5 mA/6.0 mA Typ
- Dual modulus prescaler : 2600 MHz prescaler (32/33 or 64/65) /1200 MHz prescaler (16/17 or 32/33)
- 23-bit shift register
- Serial input binary 14-bit programmable reference divider : $R = 3$ to 16,383
- Serial input programmable divider consisting of :
 - Binary 7-bit swallow counter : 0 to 127
 - Binary 11-bit programmable counter : 3 to 2,047
- Built-in high-speed tuning, low-noise phase comparator, current-switching type constant current circuit
- On-chip phase control for phase comparator
- On-chip phase comparator for fast lock and low noise
- Built-in digital locking detector circuit to detect PLL locking and unlocking
- Operating temperature : $T_a = -40$ to +85 °C
- Serial data format compatible with MB15F08SL

■ PIN DESCRIPTION

Pin no.		Pin name	I/O	Descriptions
TSSOP	QFN			
1	19	OSC _{IN}	I	The programmable reference divider input pin. TCXO should be connected with an AC coupling capacitor.
2	20	GND	—	Ground pin for OSC input buffer and the shift register circuit.
3	1	fin _{TX}	I	Prescaler input pin for the TX-PLL. Connection to an external VCO should be via AC coupling.
4	2	Xfin _{TX}	I	Prescaler complimentary input pin for the TX-PLL section. This pin should be grounded via a capacitor.
5	3	GND _{TX}	—	Ground pin for the TX-PLL section.
6	4	V _{CCTX}	—	Power supply voltage input pin for the TX-PLL section (except for the charge pump circuit) , the oscillator input buffer and the shift register.
7	5	PS _{TX}	I	Power saving mode control pin for the TX-PLL section. This pin must be set at "L" when the power supply is started up. (Open is prohibited.) PS _{TX} = "H" ; Normal mode/PS _{TX} = "L" ; Power saving mode
8	6	V _{pTX}	—	Power supply voltage input pin for the TX-PLL charge pump.
9	7	DOT _{TX}	O	Charge pump output pin for the TX-PLL section.
10	8	LD/fout	O	Lock detect signal output (LD) /phase comparator monitoring output (fout) .The output signal is selected by LDS bit in the serial data. LDS bit = "H" ; outputs fout signal/LDS bit = "L" ; outputs LD signal
11	9	DO _{RX}	O	Charge pump output pin for the RX-PLL section.
12	10	V _{pRX}	—	Power supply voltage input pin for the RX-PLL charge pump.
13	11	PS _{RX}	I	Power saving mode control pin for the RX-PLL section. This pin must be set at "L" when the power supply is started up. (Open is prohibited.) PS _{RX} = "H" ; Normal mode/PS _{RX} = "L" ; Power saving mode
14	12	V _{CCR_X}	—	Power supply voltage input pin for the RX-PLL section (except for the charge pump circuit)
15	13	GND _{RX}	—	Ground pin for the RX-PLL section
16	14	Xfin _{RX}	I	Prescaler complimentary input pin for the RX-PLL section. This pin should be grounded via a capacitor.
17	15	fin _{RX}	I	Prescaler input pin for the RX-PLL. Connection to an external VCO should be via AC coupling.
18	16	LE	I	Load enable signal input pin (with the schmitt trigger circuit) When LE is set "H", data in the shift register is transferred to the corresponding latch according to the control bit in a serial data.
19	17	Data	I	Serial data input pin (with the schmitt trigger circuit) Data is transferred to the corresponding latch (TX-ref. counter, TX-prog. counter, RX-ref.counter, RX-prog.counter) according to the control bit in a serial data.
20	18	Clock	I	Clock input pin for the 23-bit shift register (with a schmitt trigger circuit) One bit of data is shifted into the shift register on a rising edge of the clock.

■ BLOCK DIAGRAM



■ ABSOLUTE MAXIMUM RATINGS

Parameter		Symbol	Rating		Unit
			Min	Max	
Power supply voltage		V_{CC}	-0.5	+4.0	V
		V_p	V_{CC}	4.0	V
Input voltage		V_I	-0.5	$V_{CC} + 0.5$	V
Output voltage	LD/fout	V_O	GND	V_{CC}	V
	DotX, DORX	V_{DD}	GND	V_p	V
Storage temperature		Tstg	-55	+125	°C

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value			Unit	Remarks
		Min	Typ	Max		
Power supply voltage	V_{CC}	2.4	2.7	3.6	V	$V_{CCR_X} = V_{CCT_X}$
	V_p	V_{CC}	2.7	3.6	V	
Input voltage	V_I	GND	—	V_{CC}	V	
Operating temperature	T_a	-40	—	+85	°C	

Notes : • V_{CCR_X} , V_{PR_X} , V_{CCT_X} and V_{PT_X} must supply equal voltage.

Even if either RX-PLL or TX-PLL is not used, power must be supplied to V_{CCR_X} , V_{PR_X} , V_{CCT_X} and V_{PT_X} to keep them equal.

It is recommended that the non-use PLL is controlled by power saving function.

- Although this device contains an anti-static element to prevent electrostatic breakdown and the circuitry has been improved in electrostatic protection, observe the following precautions when handling the device.
 - When storing and transporting the device, put it in a conductive case.
 - Before handling the device, confirm the (jigs and) tools to be used have been uncharged (grounded) as well as yourself. Use a conductive sheet on working bench.
 - Before fitting the device into or removing it from the socket, turn the power supply off.
 - When handling (such as transporting) the device mounted board, protect the leads with a conductive sheet.

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges.

Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

MB15F78UL

■ ELECTRICAL CHARACTERISTICS

($V_{CC} = 2.4 \text{ V to } 3.6 \text{ V}$, $T_a = -40 \text{ }^\circ\text{C to } +85 \text{ }^\circ\text{C}$)

Parameter	Symbol	Condition	Value			Unit	
			Min	Typ	Max		
Power supply current	$I_{CC_{TX}}$ *1	$f_{in_{TX}} = 910 \text{ MHz}$ $V_{CC_{TX}} = V_{p_{TX}} = 2.7 \text{ V}$	1.1	1.7	2.4	mA	
	$I_{CC_{RX}}$ *1	$f_{in_{RX}} = 2500 \text{ MHz}$ $V_{CC_{RX}} = V_{p_{RX}} = 2.7 \text{ V}$	1.8	2.8	3.9	mA	
Power saving current	$I_{P_{STX}}$	$PS_{TX} = PS_{RX} = \text{"L"}$	—	0.1*2	10	μA	
	$I_{P_{SRX}}$	$PS_{TX} = PS_{RX} = \text{"L"}$	—	0.1*2	10	μA	
Operating frequency	$f_{in_{TX}}$ *3	$f_{in_{TX}}$	TX PLL	100	—	1200	MHz
	$f_{in_{RX}}$ *3	$f_{in_{RX}}$	RX PLL	400	—	2600	MHz
	OSC_{IN}	f_{OSC}	—	3	—	40	MHz
Input sensitivity	$f_{in_{TX}}$	$P_{f_{in_{TX}}}$	TX PLL, 50 Ω system	-15	—	+2	dBm
	$f_{in_{RX}}$	$P_{f_{in_{RX}}}$	RX PLL, 50 Ω system	-15	—	+2	dBm
	OSC_{IN}	V_{OSC}	—	0.5	—	V_{CC}	V_{P-P}
"H" level input voltage	Data, LE, Clock	V_{IH}	Schmitt trigger input	$0.7 V_{CC} + 0.4$	—	—	V
"L" level input voltage	Data, LE, Clock	V_{IL}	Schmitt trigger input	—	—	$0.3 V_{CC} - 0.4$	V
"H" level input voltage	PS_{TX} , PS_{RX}	V_{IH}	—	$0.7 V_{CC}$	—	—	V
"L" level input voltage	PS_{TX} , PS_{RX}	V_{IL}	—	—	—	$0.3 V_{CC}$	V
"H" level input current	Data, LE, Clock, PS_{TX} , PS_{RX}	I_{IH} *4	—	-1.0	—	+1.0	μA
"L" level input current	Data, LE, Clock, PS_{TX} , PS_{RX}	I_{IL} *4	—	-1.0	—	+1.0	μA
"H" level input current	OSC_{IN}	I_{IH}	—	0	—	+100	μA
"L" level input current	OSC_{IN}	I_{IL} *4	—	-100	—	0	μA
"H" level output voltage	LD/fout	V_{OH}	$V_{CC} = V_p = 2.7 \text{ V}$, $I_{OH} = -1 \text{ mA}$	$V_{CC} - 0.4$	—	—	V
"L" level output voltage	LD/fout	V_{OL}	$V_{CC} = V_p = 2.7 \text{ V}$, $I_{OL} = 1 \text{ mA}$	—	—	0.4	V
"H" level output voltage	Do_{TX} , Do_{RX}	V_{DOH}	$V_{CC} = V_p = 2.7 \text{ V}$, $I_{DOH} = -0.5 \text{ mA}$	$V_p - 0.4$	—	—	V
"L" level output voltage	Do_{TX} , Do_{RX}	V_{DOL}	$V_{CC} = V_p = 2.7 \text{ V}$, $I_{DOL} = 0.5 \text{ mA}$	—	—	0.4	V
High impedance cutoff current	Do_{TX} , Do_{RX}	I_{OFF}	$V_{CC} = V_p = 2.7 \text{ V}$, $V_{OFF} = 0.5 \text{ V to } V_p - 0.5 \text{ V}$	—	—	2.5	nA
"H" level output current	LD/fout	I_{OH} *4	$V_{CC} = V_p = 2.7 \text{ V}$	—	—	-1.0	mA
"L" level output current	LD/fout	I_{OL}	$V_{CC} = V_p = 2.7 \text{ V}$	1.0	—	—	mA

(Continued)

(Continued)

(V_{CC} = 2.4 V to 3.6 V, Ta = -40 °C to +85 °C)

Parameter	Symbol	Condition	Value			Unit	
			Min	Typ	Max		
“H” level output current	Do _{TX} *8, Do _{RX}	I _{DOH} *4 V _{CC} =V _p =2.7 V, V _{DOH} = V _p / 2, Ta = +25 °C	CS bit = “H”	-8.2	-6.0	-4.1	mA
			CS bit = “L”	-2.2	-1.5	-0.8	mA
“L” level output current	Do _{TX} *8, Do _{RX}	I _{DOL} V _{CC} =V _p =2.7 V, V _{DOL} = V _p / 2, Ta = +25 °C	CS bit = “H”	4.1	6.0	8.2	mA
			CS bit = “L”	0.8	1.5	2.2	mA
Charge pump current rate	I _{DOL} /I _{DOH}	I _{DOMT} *5 V _{DO} = V _p / 2	—	3	—	%	
	vs V _{DO}	I _{DOVD} *6 0.5 V ≤ V _{DO} ≤ V _p - 0.5 V	—	10	—	%	
	vs Ta	I _{DOTA} *7 -40 °C ≤ Ta ≤ +85 °C, V _{DO} = V _p / 2	—	5	—	%	

*1 : Conditions ; fosc = 12.8 MHz, Ta = +25 °C, SW = “L” in locking state.

*2 : V_{CCTX} = V_{PTX} = V_{CCRX} = V_{PRX} = 2.7 V, fosc = 12.8 MHz, Ta = +25 °C, in power saving mode.

PS_{TX} = PS_{RX} = GND

V_{IH} = V_{CC}, V_{IL} = GND (at CLK, Data, LE)

*3 : AC coupling. 1000 pF capacitor is connected under the condition of minimum operating frequency.

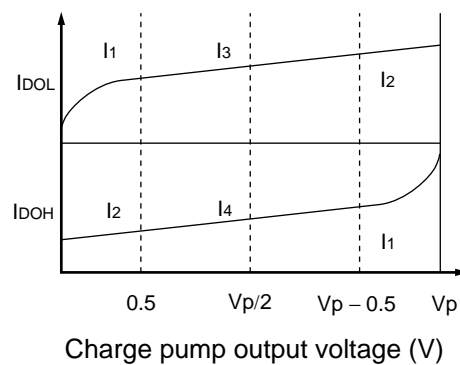
*4 : The symbol “-” (minus) means the direction of current flow.

*5 : V_{CC} = V_p = 2.7 V, Ta = +25 °C ((|I₃| - |I₄|) / [(|I₃| + |I₄|) / 2]) × 100 (%)

*6 : V_{CC} = V_p = 2.7 V, Ta = +25 °C [(|I₂| - |I₁|) / 2] / [(|I₁| + |I₂|) / 2] × 100 (%) (Applied to both I_{DOL} and I_{DOH})

*7 : V_{CC} = V_p = 2.7 V, [(|I_{DO} (+85 °C)| - |I_{DO} (-40 °C)|) / 2] / [(|I_{DO} (+85 °C)| + |I_{DO} (-40 °C)|) / 2] × 100 (%) (Applied to both I_{DOL} and I_{DOH})

*8 : When Charge pump current is measured, set LDS = “L”, T1 = “L” and T2 = “H”.



■ FUNCTIONAL DESCRIPTION

1. Pulse swallow function

$$f_{VCO} = [(P \times N) + A] \times f_{osc} \div R$$

f_{VCO} : Output frequency of external voltage controlled oscillator (VCO)

P : Preset divide ratio of dual modulus prescaler (16 or 32 for TX-PLL, 32 or 64 for RX-PLL)

N : Preset divide ratio of binary 11-bit programmable counter (3 to 2,047)

A : Preset divide ratio of binary 7-bit swallow counter ($0 \leq A \leq 127, A < N$)

f_{osc} : Reference oscillation frequency (OSC_{IN} input frequency)

R : Preset divide ratio of binary 14-bit programmable reference counter (3 to 16,383)

2. Serial Data Input

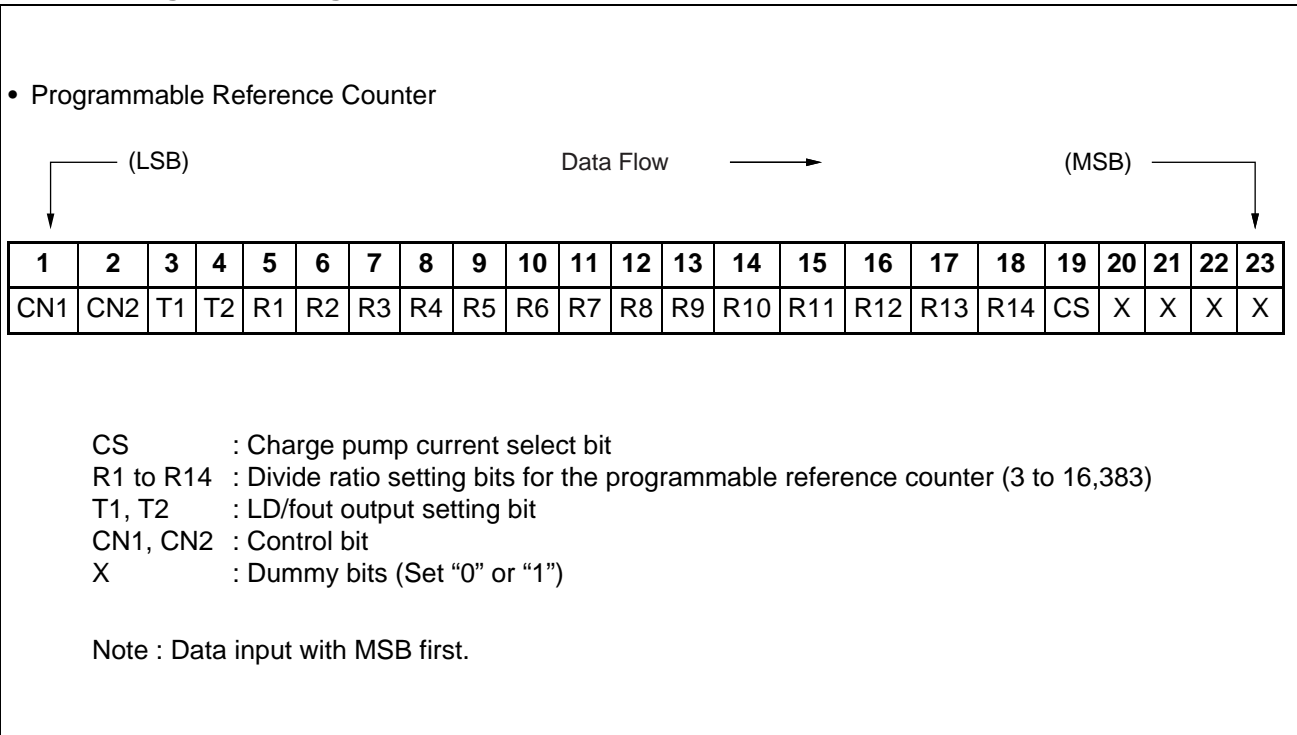
The serial data is entered using three pins, Data pin, Clock pin, and LE pin. Programmable dividers of TX/RX-PLL sections, programmable reference dividers of TX/RX-PLL sections are controlled individually.

The serial data of binary data is entered through Data pin.

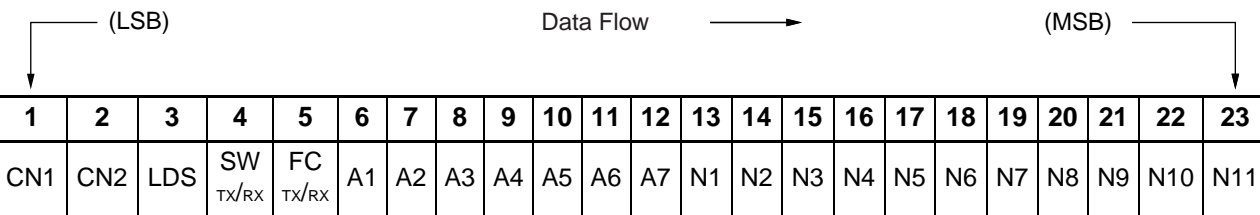
On rising edge of Clock, one bit of the serial data is transferred into the shift register. On a rising edge of load enable signal, the data stored in the shift register is transferred to one of latches depending upon the control bit data setting.

	The programmable reference counter for the TX-PLL	The programmable reference counter for the RX-PL	The programmable counter and the swallow counter for the TX-PLL	The programmable counter and the swallow counter for the RX-PLL
CN1	0	1	0	1
CN2	0	0	1	1

(1) Shift Register Configuration



• Programmable Counter



- A1 to A7 : Divide ratio setting bits for the swallow counter (0 to 127)
 - N1 to N11 : Divide ratio setting bits for the programmable counter (3 to 2,047)
 - LDS : LD/fout signal select bit
 - SW_{TX/RX} : Divide ratio setting bit for the prescaler (TX : SW_{TX}, RX : SW_{RX})
 - FC_{TX/RX} : Phase control bit for the phase detector (TX : FC_{TX}, RX : FC_{RX})
 - CN1, CN2 : Control bit
- Note : Data input with MSB first.

(2) Data setting

• Binary 14-bit Programmable Reference Counter Data Setting

Divide ratio	R14	R13	R12	R11	R10	R9	R8	R7	R6	R5	R4	R3	R2	R1
3	0	0	0	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•	•	•	•	•	•	•	•
16383	1	1	1	1	1	1	1	1	1	1	1	1	1	1

Note : Divide ratio less than 3 is prohibited.

• Binary 11-bit Programmable Counter Data Setting

Divide ratio	N11	N10	N9	N8	N7	N6	N5	N4	N3	N2	N1
3	0	0	0	0	0	0	0	0	0	1	1
4	0	0	0	0	0	0	0	0	1	0	0
•	•	•	•	•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•	•	•	•	•
2047	1	1	1	1	1	1	1	1	1	1	1

Note : Divide ratio less than 3 is prohibited.

• Binary 7-bit Swallow Counter Data Setting

Divide ratio	A7	A6	A5	A4	A3	A2	A1
0	0	0	0	0	0	0	0
1	0	0	0	0	0	0	1
•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•
•	•	•	•	•	•	•	•
127	1	1	1	1	1	1	1

MB15F78UL

- Prescaler Data Setting

Divide ratio	SW = "H"	SW = "L"
Prescaler divide ratio TX-PLL	16/17	32/33
Prescaler divide ratio RX-PLL	32/33	64/65

- Charge Pump Current Setting

Current value	CS
±6.0 mA	1
±1.5 mA	0

- LD/fout output Selectable Bit Setting

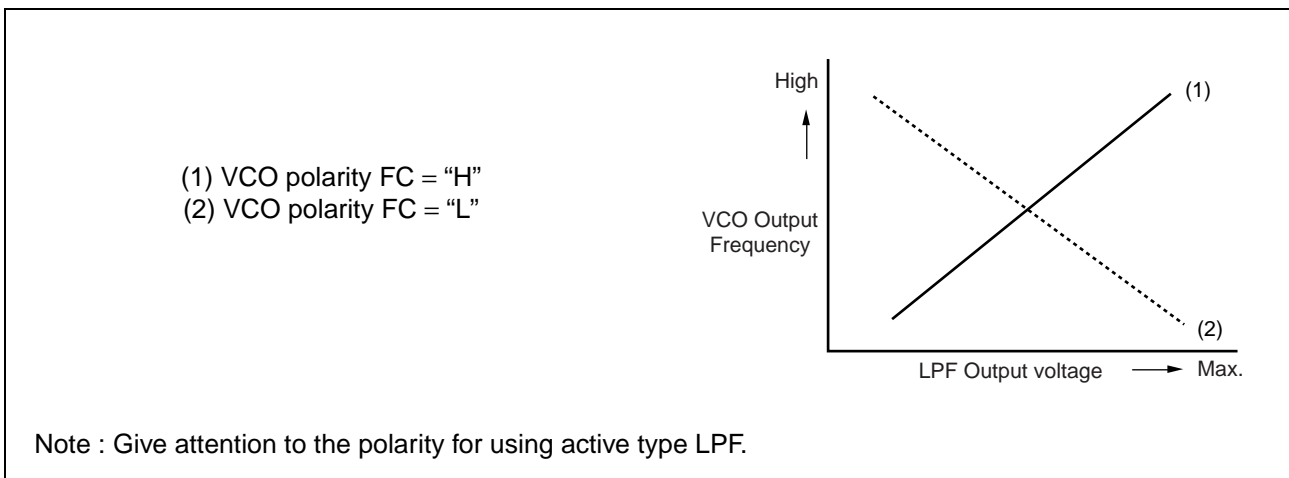
LD/fout pin state		LDS	T1	T2
LD output		0	0	0
		0	1	0
		0	1	1
fout output	frTX	1	0	0
	frRX	1	1	0
	fpTX	1	0	1
	fpRX	1	1	1

- Phase Comparator Phase Switching Data Setting

Phase comparator input	FC = "H"	FC = "L"
	DoTX/DoRX	DoTX/DoRX
fr > fp	H	L
fr < fp	L	H
fr = fp	Z	Z

Z : High-impedance

Depending upon the VCO and LPF polarity, FC bit should be set.



3. Power Saving Mode (Intermittent Mode Control Circuit)

Status	PS _{TX} /PS _{RX} pins
Normal mode	H
Power saving mode	L

The intermittent mode control circuit reduces the PLL power consumption.

By setting the PS pins low, the device enters into the power saving mode, reducing the current consumption. See the Electrical Characteristics chart for the specific value.

The phase detector output, Do, becomes high impedance.

For the dual PLL, the lock detector, LD, is as shown in the LD Output Logic table.

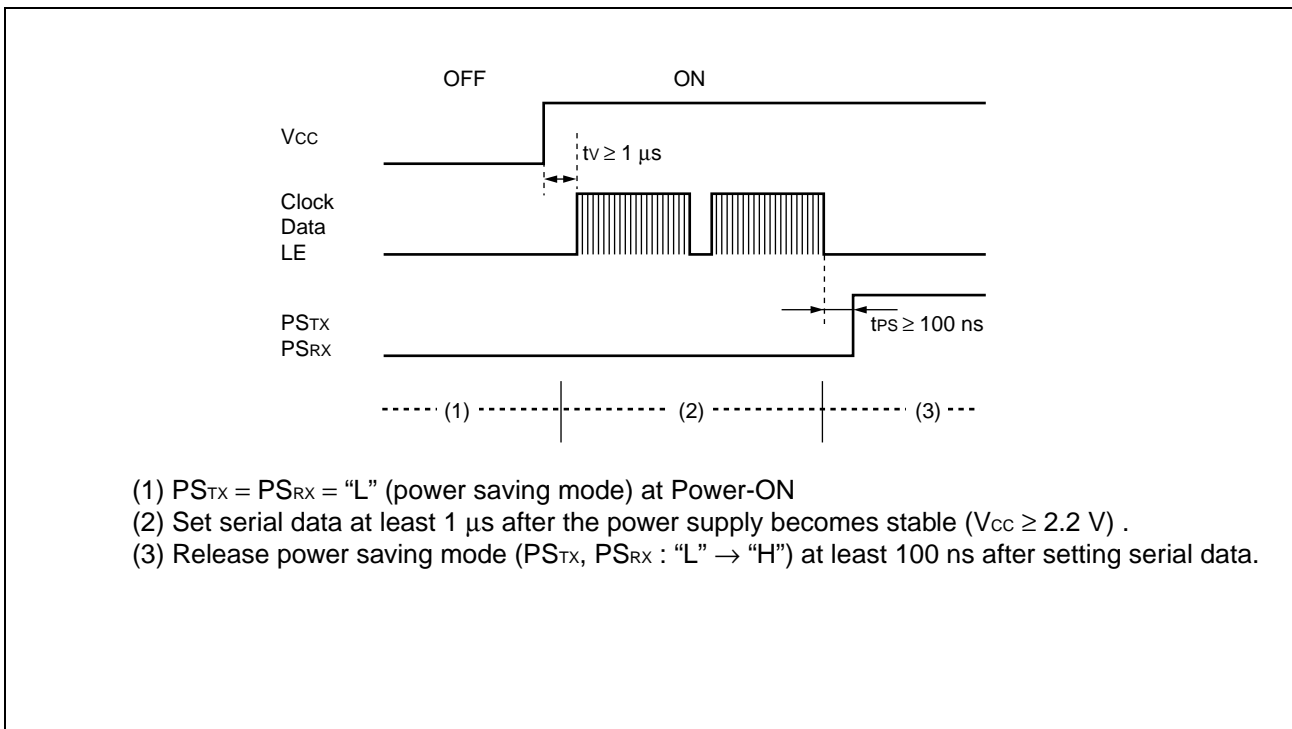
Setting the PS pins high, releases the power saving mode, and the device works normally.

The intermittent mode control circuit also ensures a smooth startup when the device returns to normal operation.

When the PLL is returned to normal operation, the phase comparator output signal is unpredictable. This is because of the unknown relationship between the comparison frequency (f_p) and the reference frequency (f_r) which can cause a major change in the comparator output, resulting in a VCO frequency jump and an increase in lockup time.

To prevent a major VCO frequency jump, the intermittent mode control circuit limits the magnitude of the error signal from the phase detector when it returns to normal operation.

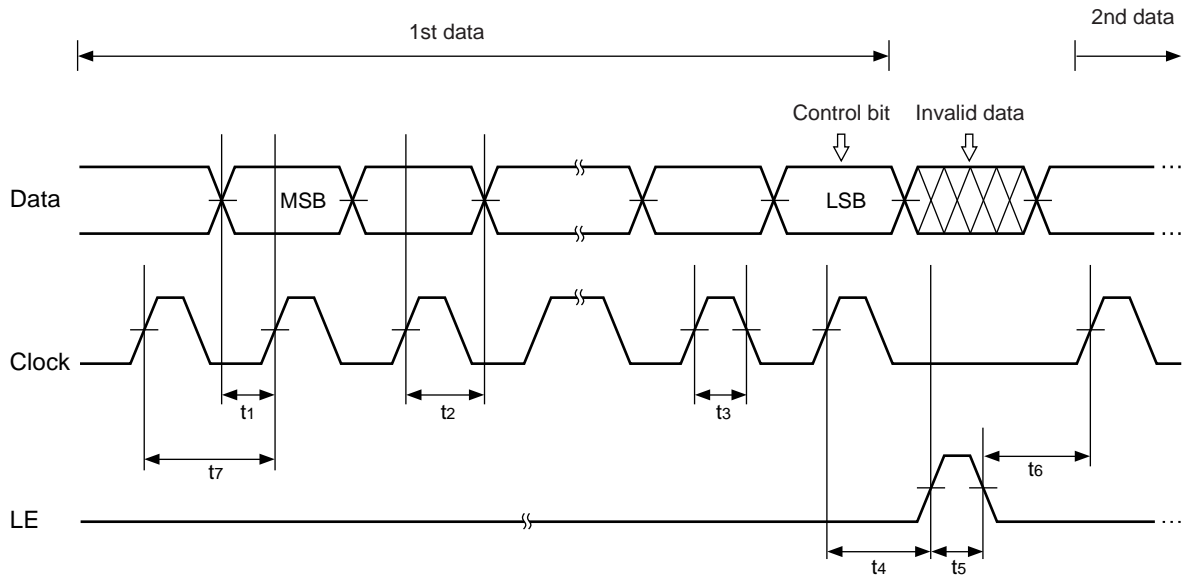
- Notes :
- When power (V_{CC}) is first applied, the device must be in standby mode, PS_{TX} = PS_{RX} = Low, for at least 1 μ s.
 - PS pins must be set at "L" at Power-ON



4. Serial data input timing

Divide ratio setting is performed through a serial interface using the Data pin, Clock pin, and LE pin.

Setting data is read into the shift register at the rise of the Clock signal, and transferred to a latch at the rise of the LE signal. The following diagram shows the data input timing.

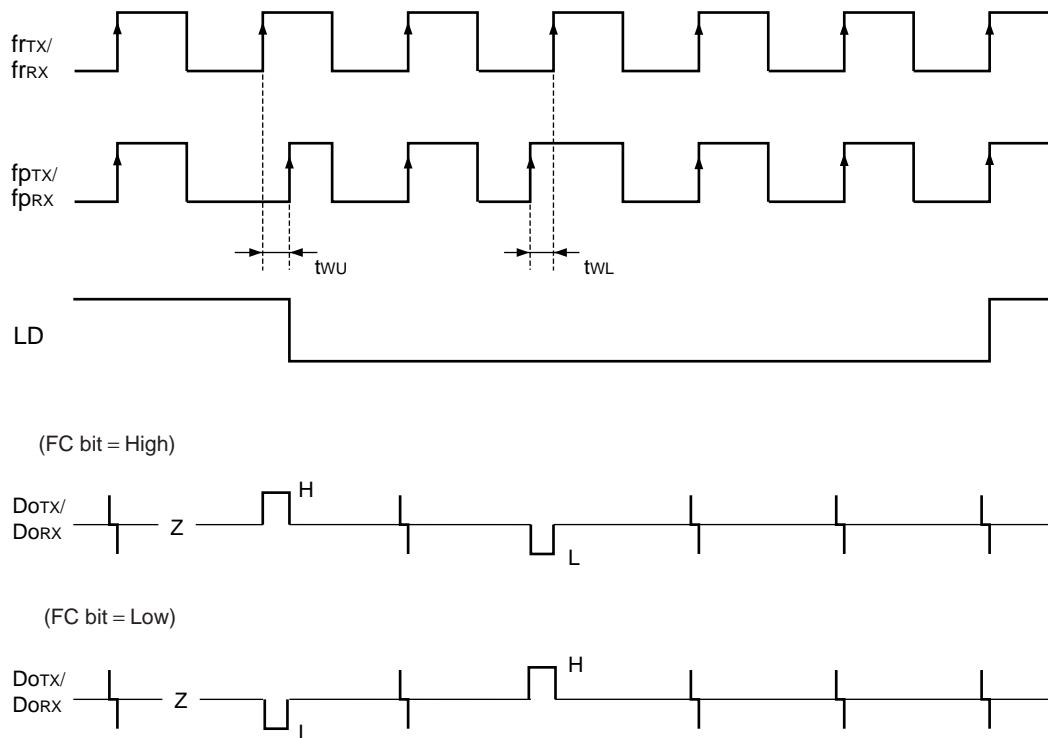


Parameter	Min	Typ	Max	Unit
t ₁	20	—	—	ns
t ₂	20	—	—	ns
t ₃	30	—	—	ns
t ₄	30	—	—	ns

Parameter	Min	Typ	Max	Unit
t ₅	100	—	—	ns
t ₆	20	—	—	ns
t ₇	100	—	—	ns

Note : LE should be "L" when the data is transferred into the shift register.

■ PHASE COMPARATOR OUTPUT WAVEFORM



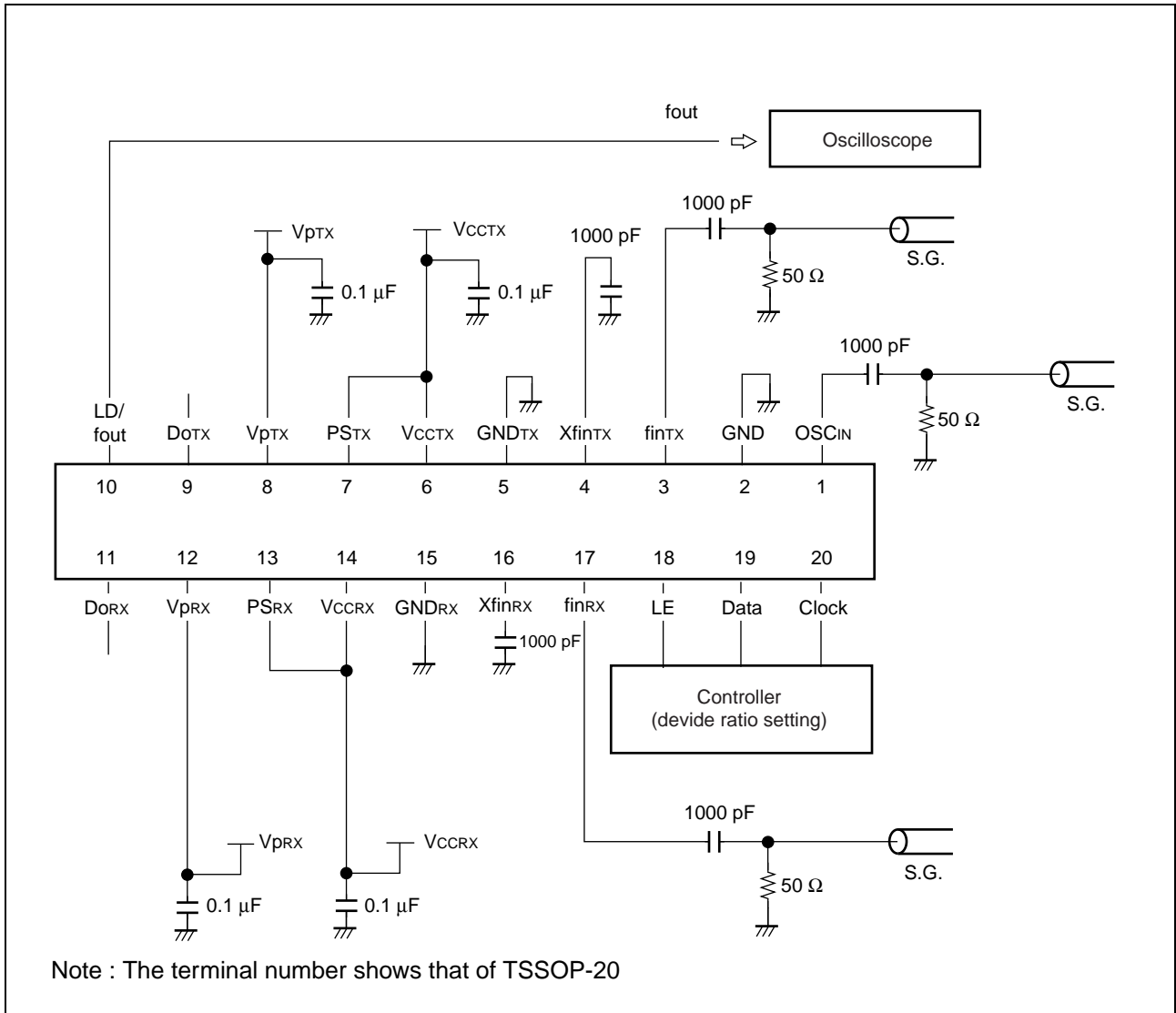
LD Output Logic Table

TX-PLL section	RX-PLL section	LD output
Locking state/Power saving state	Locking state/Power saving state	H
Locking state/Power saving state	Unlocking state	L
Unlocking state	Locking state/Power saving state	L
Unlocking state	Unlocking state	L

- Notes :
- Phase error detection range = -2π to $+2\pi$
 - Pulses on DoTX/DoRX signals are output to prevent dead zone.
 - LD output becomes low when phase error is t_{wU} or more.
 - LD output becomes high when phase error is t_{wL} or less and continues to be so for three cycles or more.
 - t_{wU} and t_{wL} depend on OSC_{IN} input frequency as follows.
 - $t_{wU} \geq 2/f_{osc}$: e.g. $t_{wU} \geq 156.3$ ns when $f_{osc} = 12.8$ MHz
 - $t_{wL} \leq 4/f_{osc}$: e.g. $t_{wL} \leq 312.5$ ns when $f_{osc} = 12.8$ MHz

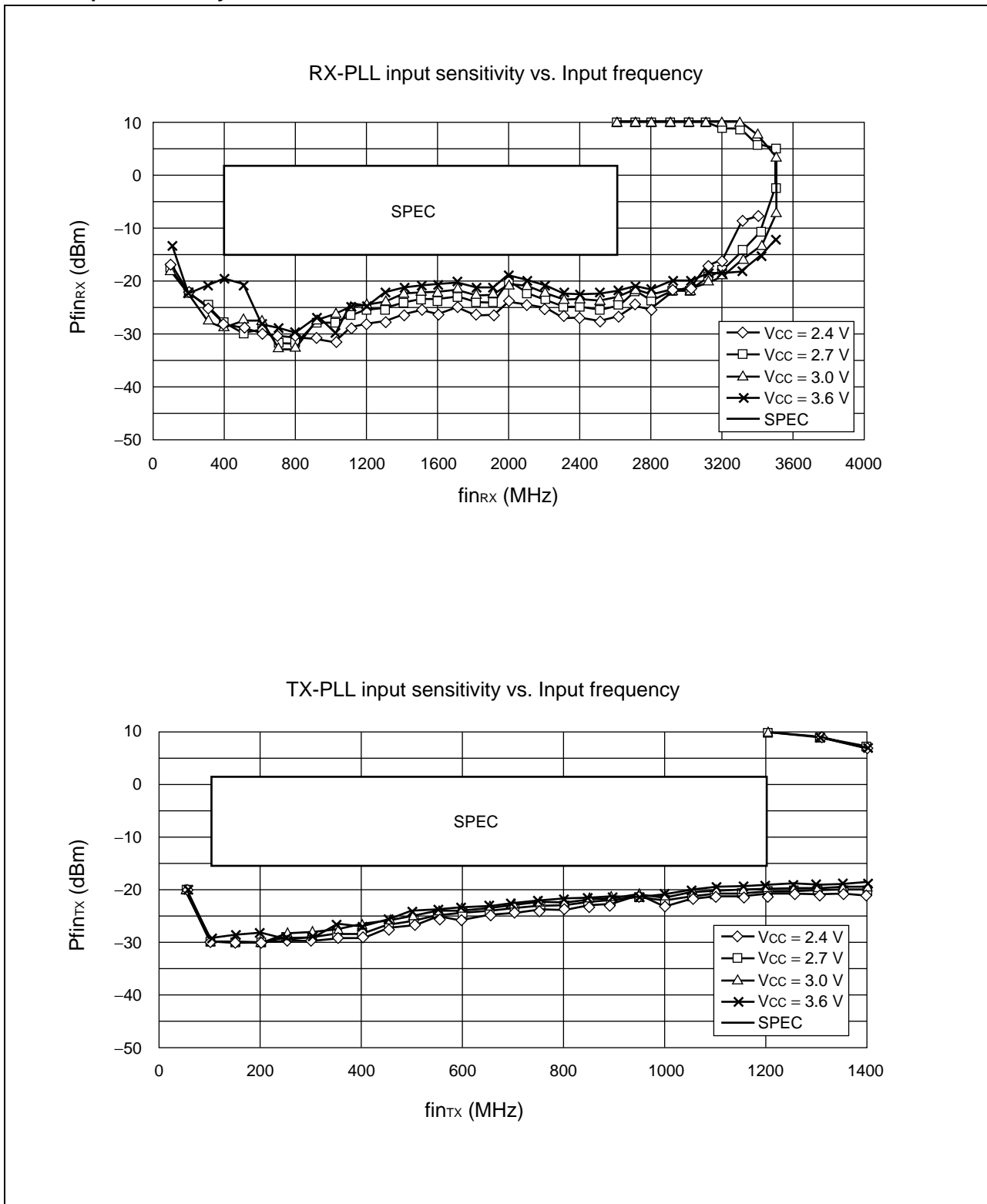
MB15F78UL

■ TEST CIRCUIT (for Measuring Input Sensitivity f_{in}/OSC_{IN})

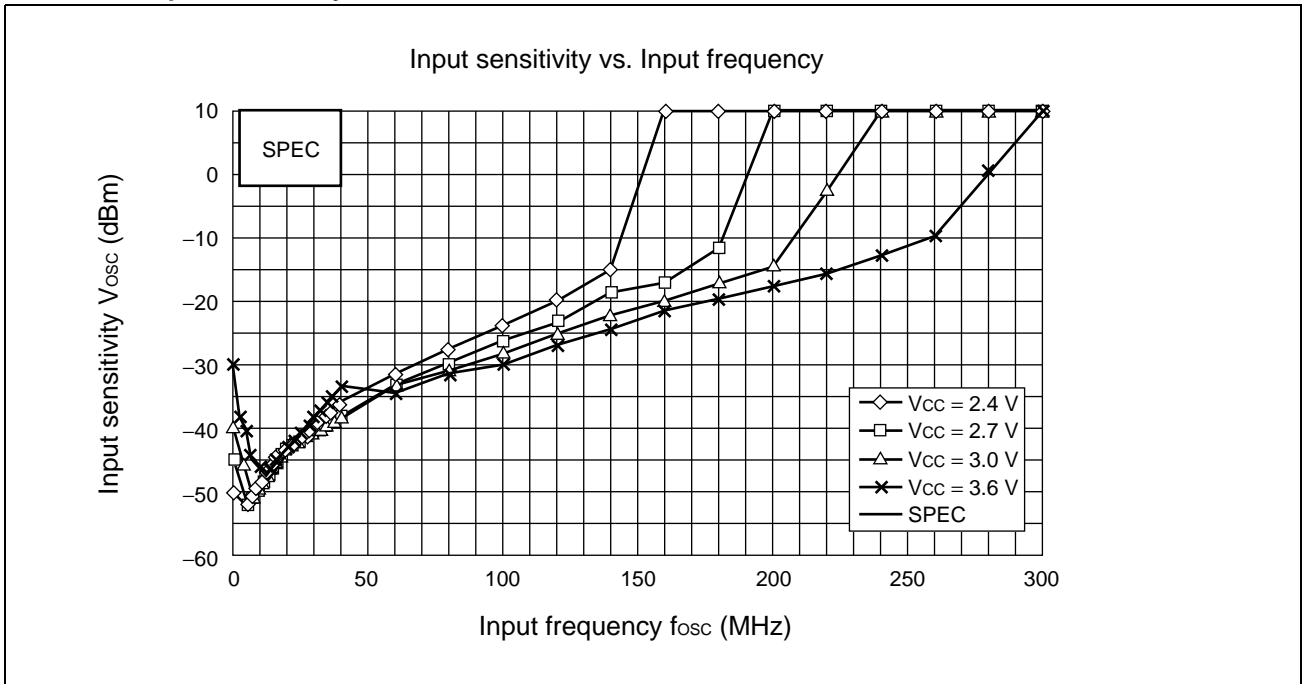


■ TYPICAL CHARACTERISTICS

1. fin input sensitivity

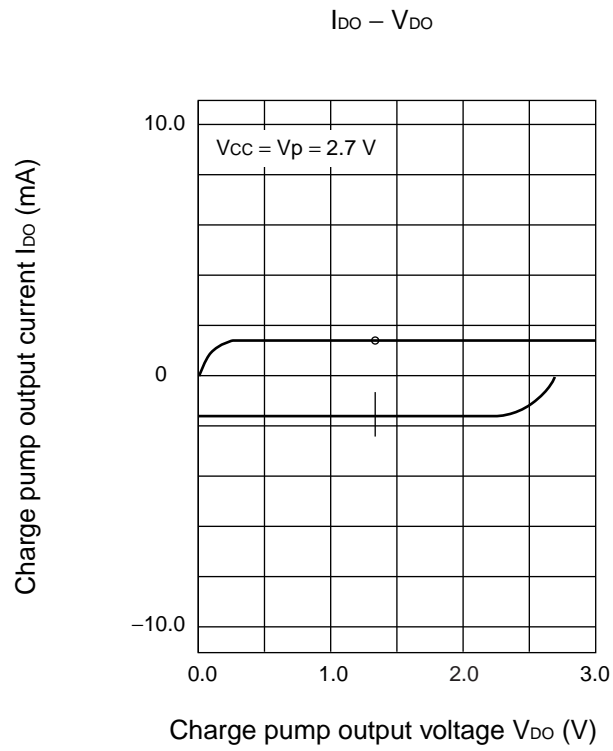


2. OSC_{IN} input sensitivity

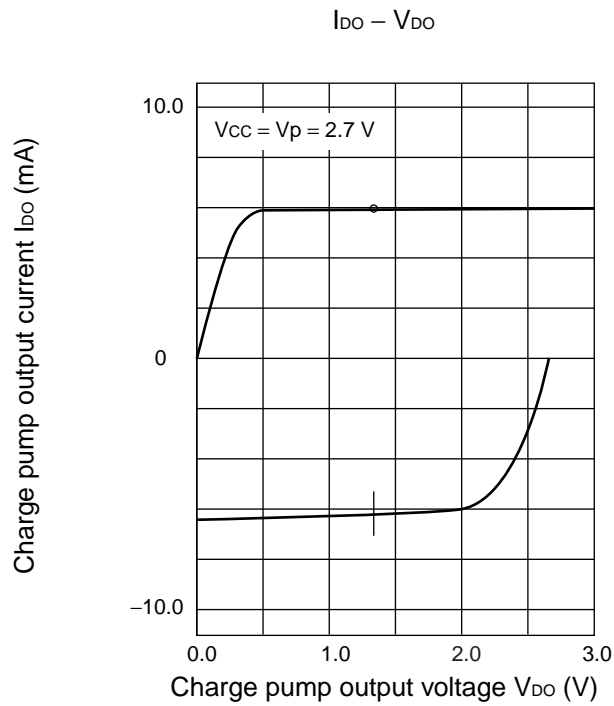


3. Do output current (RX PLL)

- 1.5 mA mode

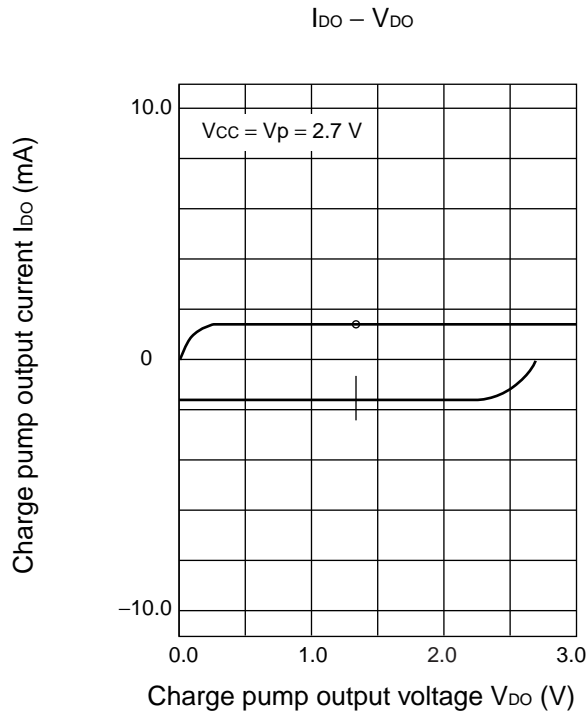


- 6.0 mA mode

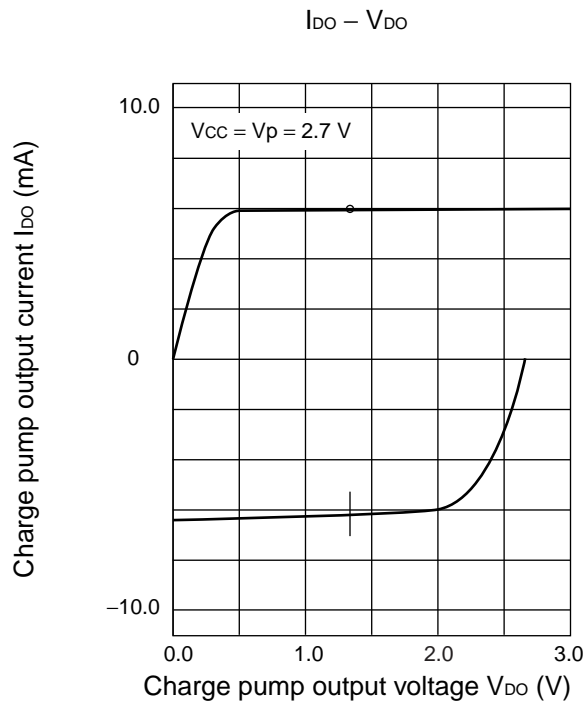


4. Do output current (TX PLL)

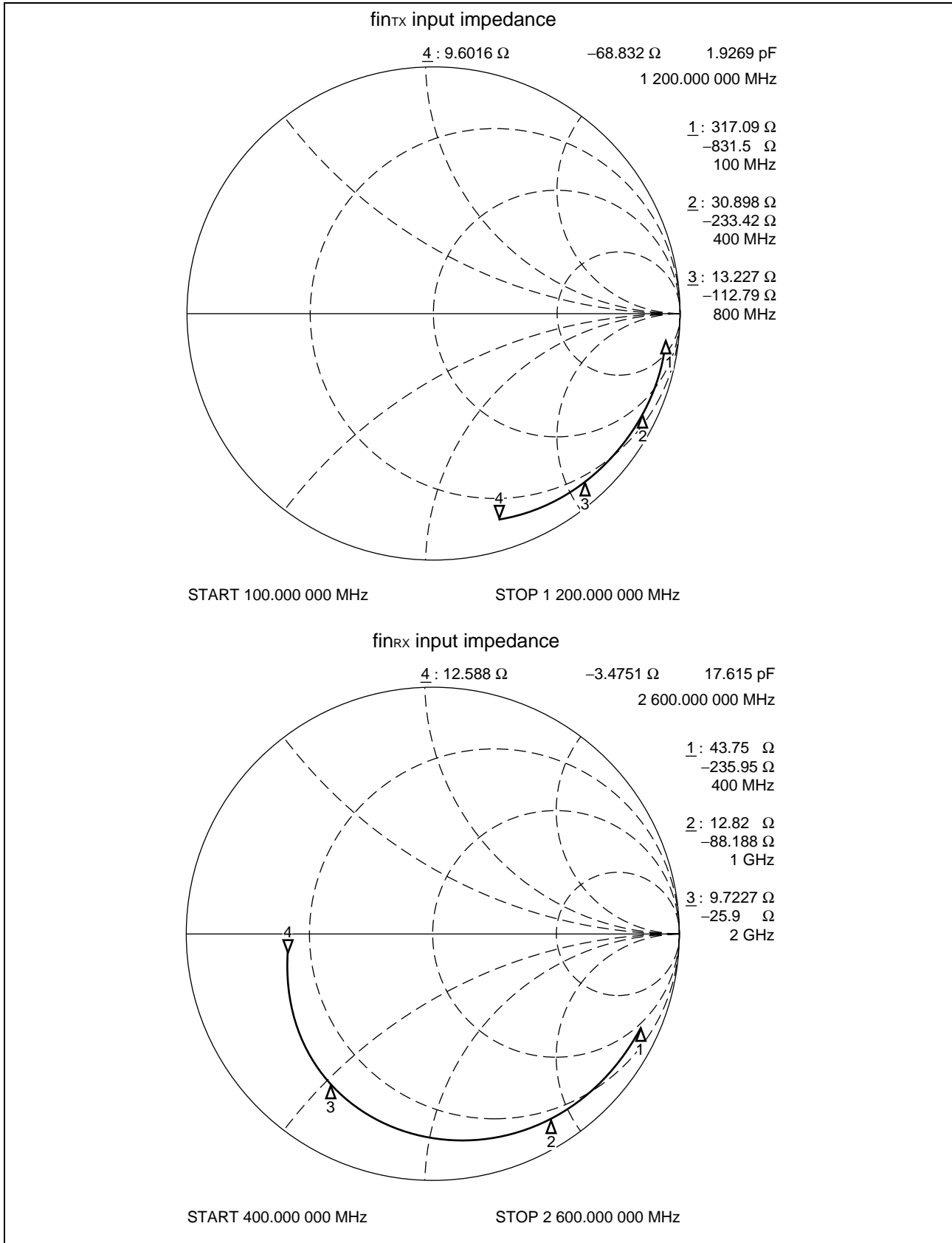
- 1.5 mA mode



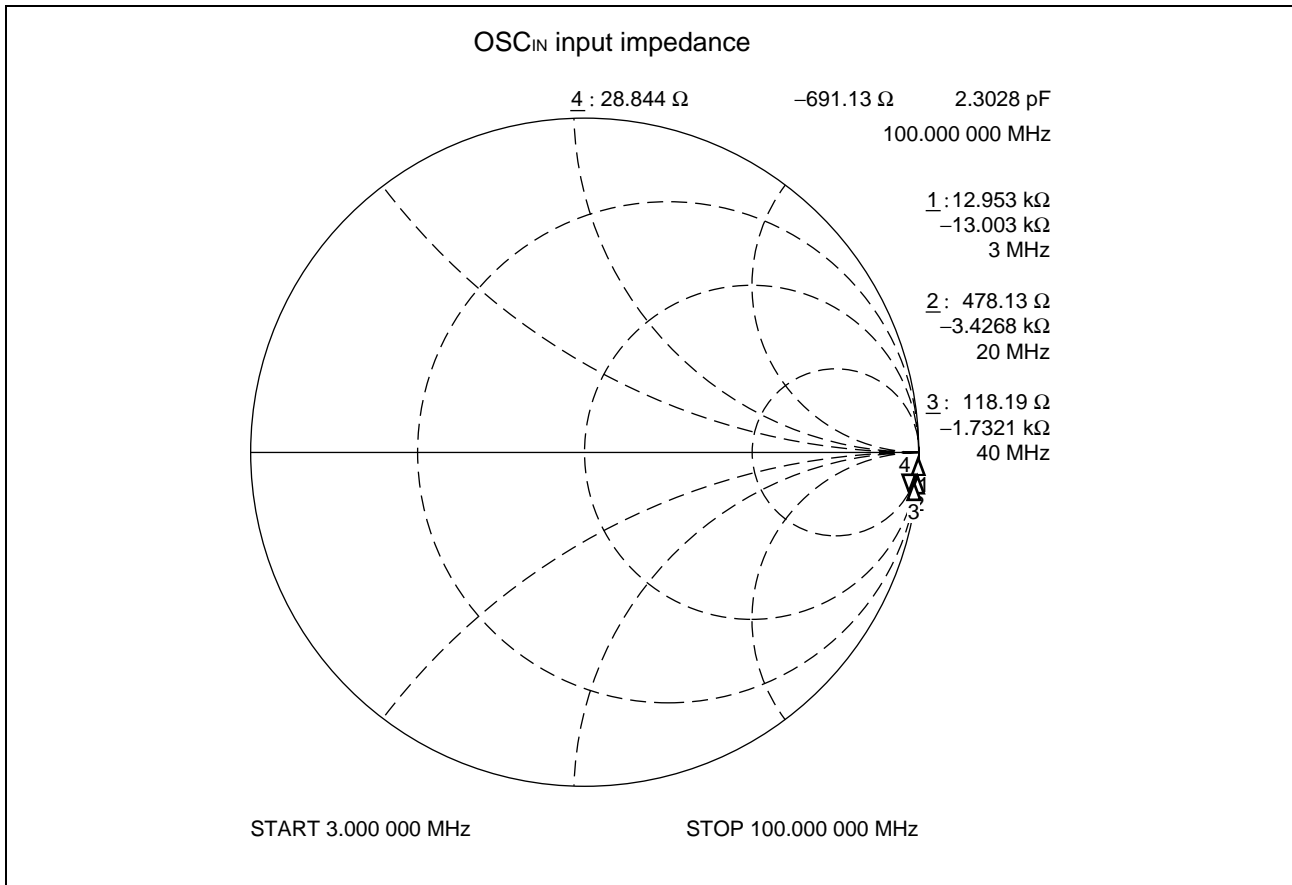
- 6.0 mA mode



5. fin input impedance

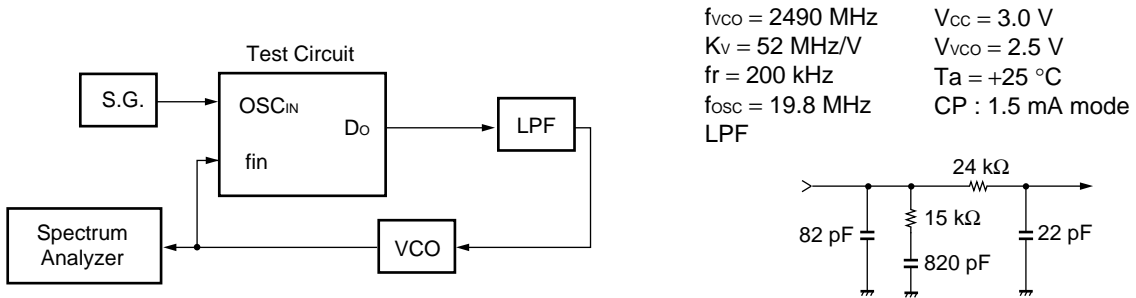


6. OSC_{IN} input impedance

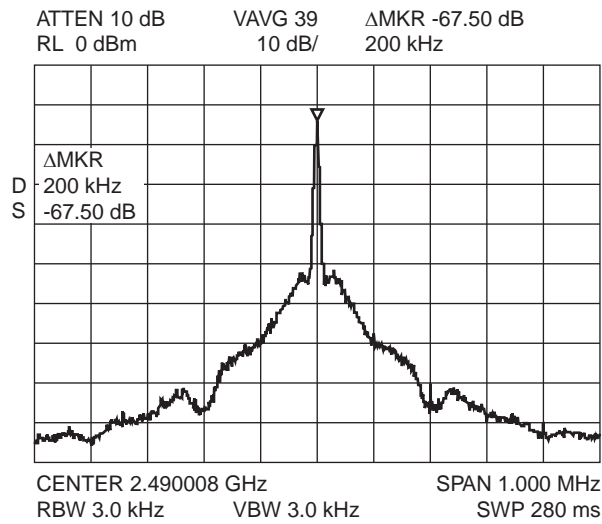


■ REFERENCE INFORMATION

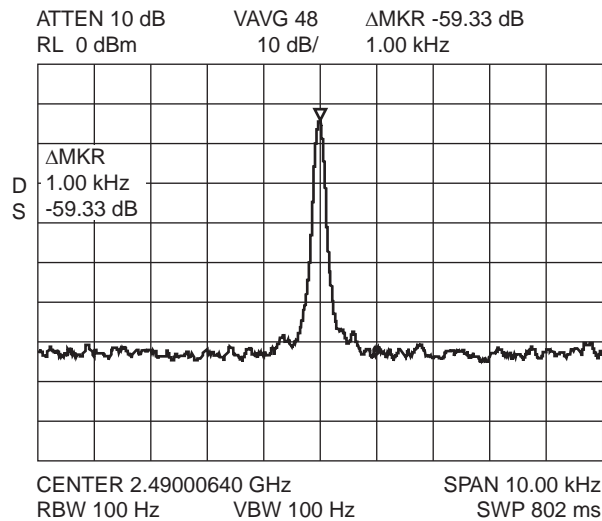
(for Look-up time, Phase noise and Reference leakage)



• PLL Reference Leakage



• PLL Phase Noise

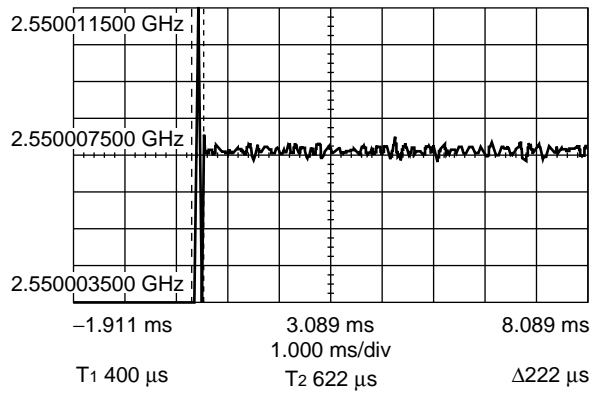


(Continued)

(Continued)

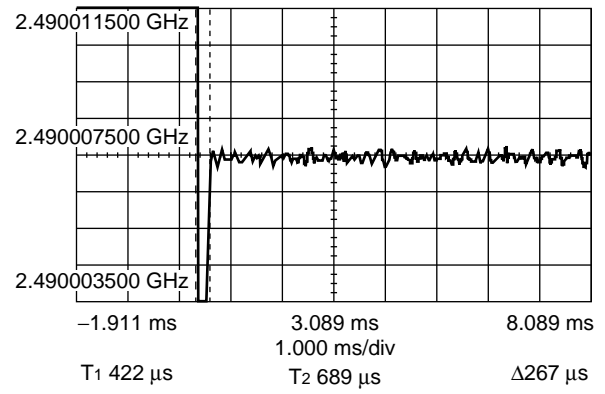
• PLL Lock-up time

2.49 GHz → 2.55 GHz within ± 1 kHz
Lch → Hch 222 μ s

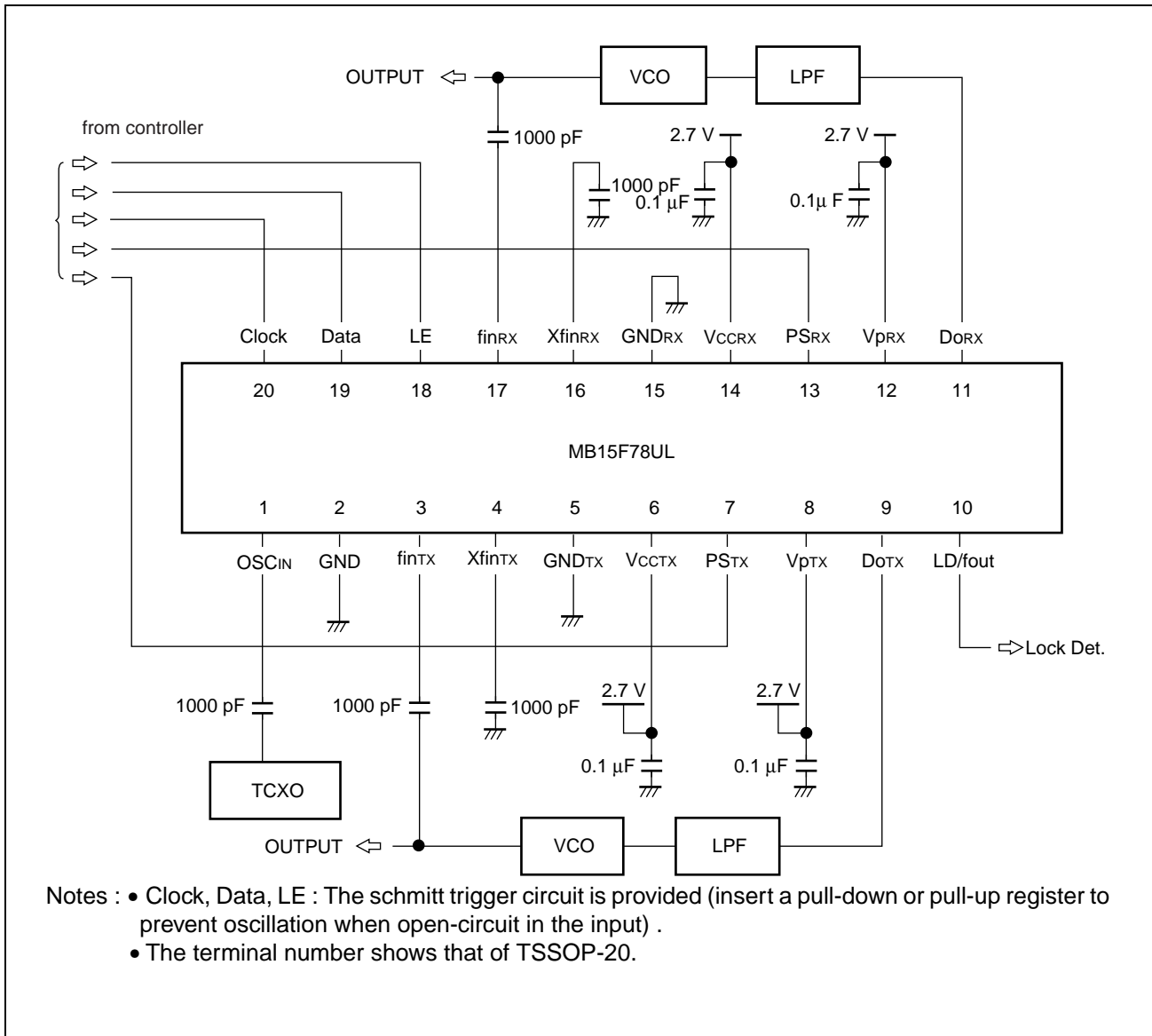


• PLL Lock-up time

2.55 GHz → 2.49 GHz within ± 1 kHz
Hch → Lch 267 μ s



APPLICATION EXAMPLE



■ USAGE PRECAUTIONS

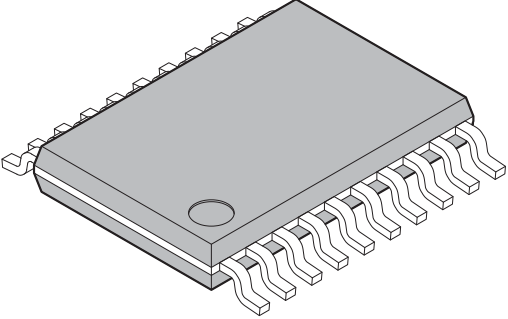
- (1) $V_{CCR\text{X}}$, $V_{p\text{R}\text{X}}$, $V_{C\text{C}\text{T}\text{X}}$ and $V_{p\text{T}\text{X}}$ must be equal voltage.
Even if either RX-PLL or TX-PLL is not used, power must be supplied to $V_{CCR\text{X}}$, $V_{p\text{R}\text{X}}$, $V_{C\text{C}\text{T}\text{X}}$ and $V_{p\text{T}\text{X}}$ to keep them equal. It is recommended that the non-use PLL is controlled by power saving function.
- (2) To protect against damage by electrostatic discharge, note the following handling precautions :
 - Store and transport devices in conductive containers.
 - Use properly grounded workstations, tools, and equipment.
 - Turn off power before inserting or removing this device into or from a socket.
 - Protect leads with conductive sheet, when transporting a board mounted device.

■ ORDERING INFORMATION

Part number	Package	Remarks
MB15F78ULPFT	20-pin, plastic TSSOP (FPT-20P-M06)	
MB15F78ULWQN	20-pin, plastic QFN (LCC-20P-M63)	

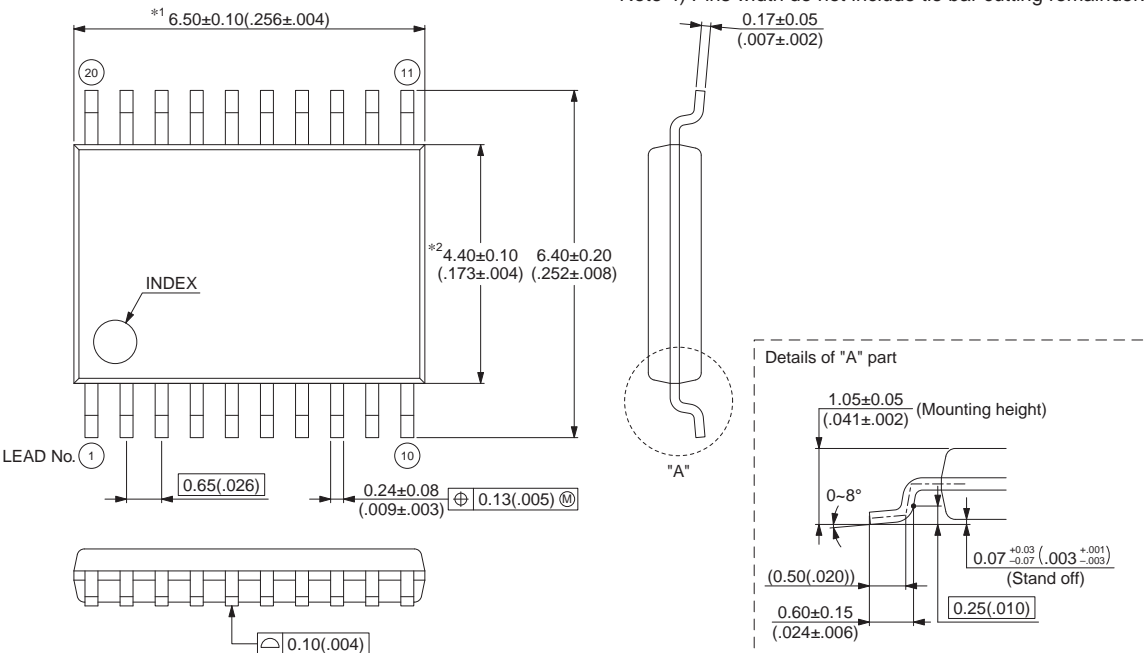
MB15F78UL

PACKAGE DIMENSIONS

<p>20-pin plastic TSSOP</p>  <p>(FPT-20P-M06)</p>	Lead pitch	0.65 mm
	Package width × package length	4.40 × 6.50 mm
	Lead shape	Gullwing
	Sealing method	Plastic mold
	Mounting height	1.10 mm MAX
	Weight	0.08g
	Code (Reference)	P-TSSOP20-4.4×6.5-0.65

20-pin plastic TSSOP (FPT-20P-M06)

Note 1) *1 : Resin protrusion. (Each side : +0.15 (.006) Max).
 Note 2) *2 : These dimensions do not include resin protrusion.
 Note 3) Pins width and pins thickness include plating thickness.
 Note 4) Pins width do not include tie bar cutting remainder.



Top view dimensions:
 *1 6.50±0.10(.256±.004)
 *2 4.40±0.10(.173±.004) 6.40±0.20(.252±.008)
 LEAD No. 1 0.65(.026) 0.24±0.08(.009±.003) 0.13(.005) Ⓜ
 INDEX
 0.10(.004)

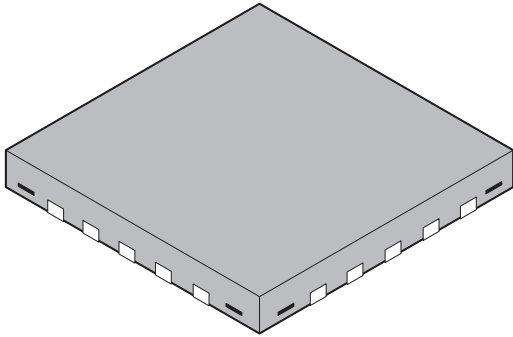
Lead detail dimensions:
 0.17±0.05(.007±.002)
 1.05±0.05(.041±.002) (Mounting height)
 0~8°
 0.07^{+0.03}/_{-0.07}(.003^{+0.001}/_{-0.003}) (Stand off)
 0.50(.020) 0.60±0.15(.024±.006) 0.25(.010)

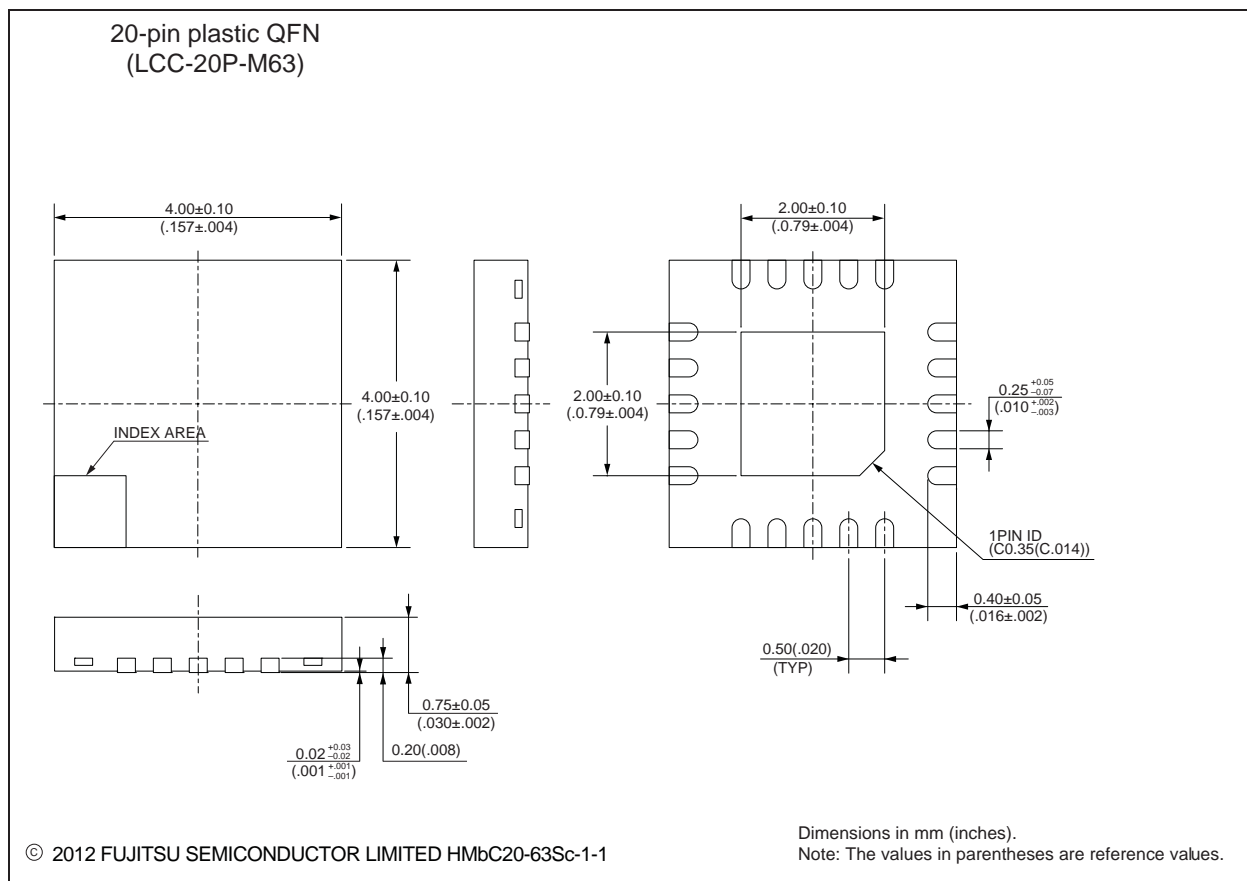
Dimensions in mm (inches).
 Note: The values in parentheses are reference values.

© 2003-2010 FUJITSU SEMICONDUCTOR LIMITED F20026S-c-3-5

(Continued)

(Continued)

<p>20-pin plastic QFN</p>  <p>(LCC-20P-M63)</p>	Lead pitch	0.50 mm	
	Package width × package length	4.00 mm × 4.00 mm	
	Sealing method	Plastic mold	
	Mounting height	0.80 mm MAX	
	Weight	0.04 g	



Please check the latest package dimension at the following URL.
<http://edevice.fujitsu.com/package/en-search/>

■ MAJOR CHANGES IN THIS EDITION

A change on a page is indicated by a vertical line drawn on the left side of that page.

Page	Section	Change Results
1	■ DESCRIPTION	Deleted the description.
	■ FEATURES	Deleted the following description. • Small package BCC20 (3.4 mm × 3.6 mm × 0.6 mm)
2	■ PIN ASSIGNMENTS	Revised the package code. LCC-20P-M05 → LCC-20P-M63
3	■ PIN DESCRIPTION	
25	■ ORDERING INFORMATION	Revised the ordering information.
27	■ PACKAGE DIMENSIONS	Revised the package code. LCC-20P-M05 → LCC-20P-M63

MEMO

MEMO

MEMO

MB15F78UL

FUJITSU SEMICONDUCTOR LIMITED

Nomura Fudosan Shin-yokohama Bldg. 10-23, Shin-yokohama 2-Chome,
Kohoku-ku Yokohama Kanagawa 222-0033, Japan

Tel: +81-45-415-5858

<http://jp.fujitsu.com/fsl/en/>

For further information please contact:

North and South America

FUJITSU SEMICONDUCTOR AMERICA, INC.

1250 E. Arques Avenue, M/S 333

Sunnyvale, CA 94085-5401, U.S.A.

Tel: +1-408-737-5600 Fax: +1-408-737-5999

<http://us.fujitsu.com/micro/>

Asia Pacific

FUJITSU SEMICONDUCTOR ASIA PTE. LTD.

151 Lorong Chuan,

#05-08 New Tech Park 556741 Singapore

Tel : +65-6281-0770 Fax : +65-6281-0220

<http://sg.fujitsu.com/semiconductor/>

Europe

FUJITSU SEMICONDUCTOR EUROPE GmbH

Pittlerstrasse 47, 63225 Langen, Germany

Tel: +49-6103-690-0 Fax: +49-6103-690-122

<http://emea.fujitsu.com/semiconductor/>

FUJITSU SEMICONDUCTOR SHANGHAI CO., LTD.

30F, Kerry Parkside, 1155 Fang Dian Road, Pudong District,

Shanghai 201204, China

Tel : +86-21-6146-3688 Fax : +86-21-6146-3660

<http://cn.fujitsu.com/fss/>

Korea

FUJITSU SEMICONDUCTOR KOREA LTD.

902 Kosmo Tower Building, 1002 Daechi-Dong,

Gangnam-Gu, Seoul 135-280, Republic of Korea

Tel: +82-2-3484-7100 Fax: +82-2-3484-7111

<http://kr.fujitsu.com/fsk/>

FUJITSU SEMICONDUCTOR PACIFIC ASIA LTD.

2/F, Green 18 Building, Hong Kong Science Park,

Shatin, N.T., Hong Kong

Tel : +852-2736-3232 Fax : +852-2314-4207

<http://cn.fujitsu.com/fsp/>

Specifications are subject to change without notice. For further information please contact each office.

All Rights Reserved.

The contents of this document are subject to change without notice.

Customers are advised to consult with sales representatives before ordering.

The information, such as descriptions of function and application circuit examples, in this document are presented solely for the purpose of reference to show examples of operations and uses of FUJITSU SEMICONDUCTOR device; FUJITSU SEMICONDUCTOR does not warrant proper operation of the device with respect to use based on such information. When you develop equipment incorporating the device based on such information, you must assume any responsibility arising out of such use of the information.

FUJITSU SEMICONDUCTOR assumes no liability for any damages whatsoever arising out of the use of the information.

Any information in this document, including descriptions of function and schematic diagrams, shall not be construed as license of the use or exercise of any intellectual property right, such as patent right or copyright, or any other right of FUJITSU SEMICONDUCTOR or any third party or does FUJITSU SEMICONDUCTOR warrant non-infringement of any third-party's intellectual property right or other right by using such information. FUJITSU SEMICONDUCTOR assumes no liability for any infringement of the intellectual property rights or other rights of third parties which would result from the use of information contained herein.

The products described in this document are designed, developed and manufactured as contemplated for general use, including without limitation, ordinary industrial use, general office use, personal use, and household use, but are not designed, developed and manufactured as contemplated (1) for use accompanying fatal risks or dangers that, unless extremely high safety is secured, could have a serious effect to the public, and could lead directly to death, personal injury, severe physical damage or other loss (i.e., nuclear reaction control in nuclear facility, aircraft flight control, air traffic control, mass transport control, medical life support system, missile launch control in weapon system), or (2) for use requiring extremely high reliability (i.e., submersible repeater and artificial satellite).

Please note that FUJITSU SEMICONDUCTOR will not be liable against you and/or any third party for any claims or damages arising in connection with above-mentioned uses of the products.

Any semiconductor devices have an inherent chance of failure. You must protect against injury, damage or loss from such failures by incorporating safety design measures into your facility and equipment such as redundancy, fire protection, and prevention of over-current levels and other abnormal operating conditions.

Exportation/release of any products described in this document may require necessary procedures in accordance with the regulations of the Foreign Exchange and Foreign Trade Control Law of Japan and/or US export control laws.

The company names and brand names herein are the trademarks or registered trademarks of their respective owners.

Edited: Sales Promotion Department